bq2947 Overvoltage Protection for 2-Series to 4-Series Cell Li-Ion Batteries with External Delay Capacitor

1 Features
- 2-, 3-, and 4-Series Cell Overvoltage Protection
- External Capacitor-Programmed Delay Timer
- Factory Programmed OVP Threshold (Threshold Range 3.85 V to 4.6 V)
- Output Options: Active High or Open Drain Active Low
- High-Accuracy Overvoltage Protection: ±10 mV
- Low Power Consumption $I_{CC} \approx 1 \mu A$ ($V_{CELL(ALL)} < V_{PROTECT}$)
- Low Leakage Current Per Cell Input < 100 nA
- Small Package Footprint
  - 8-Pin WSON (2.00 mm x 2.00 mm)

2 Applications
- Notebooks
- UPS Battery Backup

3 Description
The bq2947 family is an overvoltage monitor and protector for Li-Ion battery pack systems. Each cell is monitored independently for an overvoltage condition. In the bq2947 device, an external delay timer is initiated upon detection of an overvoltage condition on any cell. Upon expiration of the delay timer, the output is triggered into its active state (either high or low, depending on the configuration). The external delay timer feature also includes the ability to detect an open or shorted delay capacitor on the CD pin, which will similarly trigger the output driver in an overvoltage condition.

For quicker production-line testing, the bq2947 device provides a Customer Test Mode with reduced delay time.

Device Information

<table>
<thead>
<tr>
<th>PART NUMBER</th>
<th>PACKAGE</th>
<th>BODY SIZE (NOM)</th>
</tr>
</thead>
<tbody>
<tr>
<td>bq294700</td>
<td>WSON (8)</td>
<td>2.00 mm x 2.00 mm</td>
</tr>
</tbody>
</table>

(1) For all available packages, see the orderable addendum at the end of the data sheet.
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4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision H (February 2018) to Revision I

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Changes from Revision G (November 2017) to Revision H

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Changes from Revision F (January 2017) to Revision G

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Changes from Revision E (February 2016) to Revision F

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Changes from Revision D (November 2015) to Revision E

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Changes from Revision C (November 2015) to Revision D

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<tr>
<td>16</td>
</tr>
</tbody>
</table>
Changes from Revision B (August 2014) to Revision C

- Added preview footnote to the Device Options table .............................................................. 3
- Added bq294708 to the Device Options table ........................................................................ 3

Changes from Revision A (June 2013) to Revision B

- Added ESD Ratings table, Feature Description section, Device Functional Modes, Application and Implementation section, Power Supply Recommendations section, Layout section, Device and Documentation Support section, and Mechanical, Packaging, and Orderable Information section ............................................................. 1

Changes from Original (September 2012) to Revision A

- Added the bq294707 device to Production Data .................................................................... 1

5 Device Options

<table>
<thead>
<tr>
<th>PART NUMBER</th>
<th>OVP (V)</th>
<th>OV HYSTERESIS</th>
<th>OUTPUT DRIVE</th>
</tr>
</thead>
<tbody>
<tr>
<td>bq294700</td>
<td>4.350</td>
<td>0.300</td>
<td>CMOS Active High</td>
</tr>
<tr>
<td>bq294701</td>
<td>4.250</td>
<td>0.300</td>
<td>CMOS Active High</td>
</tr>
<tr>
<td>bq294702</td>
<td>4.300</td>
<td>0.300</td>
<td>CMOS Active High</td>
</tr>
<tr>
<td>bq294703</td>
<td>4.325</td>
<td>0.300</td>
<td>CMOS Active High</td>
</tr>
<tr>
<td>bq294704</td>
<td>4.400</td>
<td>0.300</td>
<td>CMOS Active High</td>
</tr>
<tr>
<td>bq294705</td>
<td>4.450</td>
<td>0.300</td>
<td>CMOS Active High</td>
</tr>
<tr>
<td>bq294706</td>
<td>4.550</td>
<td>0.300</td>
<td>CMOS Active High</td>
</tr>
<tr>
<td>bq294707</td>
<td>4.225</td>
<td>0.050</td>
<td>NCH Open Drain Active Low</td>
</tr>
<tr>
<td>bq294708</td>
<td>4.500</td>
<td>0.300</td>
<td>CMOS Active High</td>
</tr>
<tr>
<td>bq294711</td>
<td>4.220</td>
<td>0.300</td>
<td>CMOS Active High</td>
</tr>
<tr>
<td>bq294712(1)</td>
<td>4.125</td>
<td>0.300</td>
<td>CMOS Active High</td>
</tr>
<tr>
<td>bq294713(1)</td>
<td>4.600</td>
<td>0.300</td>
<td>CMOS Active High</td>
</tr>
<tr>
<td>bq2947</td>
<td>3.850–4.60</td>
<td>0–0.300</td>
<td>CMOS Active High or Open Drain Active Low</td>
</tr>
</tbody>
</table>

(1) Contact TI for more information.
6 Pin Configuration and Functions

Pin Functions

<table>
<thead>
<tr>
<th>NUMBER</th>
<th>NAME</th>
<th>TYPE</th>
<th>DESCRIPTION</th>
</tr>
</thead>
<tbody>
<tr>
<td>1</td>
<td>VDD</td>
<td>P</td>
<td>Power supply input</td>
</tr>
<tr>
<td>2</td>
<td>V4</td>
<td>IA</td>
<td>Sense input for positive voltage of the fourth cell from the bottom of the stack</td>
</tr>
<tr>
<td>3</td>
<td>V3</td>
<td>IA</td>
<td>Sense input for positive voltage of the third cell from the bottom of the stack</td>
</tr>
<tr>
<td>4</td>
<td>V2</td>
<td>IA</td>
<td>Sense input for positive voltage of the second cell from the bottom of the stack</td>
</tr>
<tr>
<td>5</td>
<td>V1</td>
<td>IA</td>
<td>Sense input for positive voltage of the lowest cell in the stack</td>
</tr>
<tr>
<td>6</td>
<td>VSS</td>
<td>P</td>
<td>Electrically connected to IC ground and negative terminal of the lowest cell in the stack</td>
</tr>
<tr>
<td>7</td>
<td>CD</td>
<td>OA (1)</td>
<td>External capacitor connection for delay timer</td>
</tr>
<tr>
<td>8</td>
<td>OUT</td>
<td>OA</td>
<td>Analog Output drive for overvoltage fault signal. Active High or Open Drain Active Low</td>
</tr>
<tr>
<td></td>
<td>PowerPAD™</td>
<td>P</td>
<td>TI recommends connecting the exposed pad to VSS on the PCB.</td>
</tr>
</tbody>
</table>

(1) IA = Input Analog, OA = Output Analog, P = Power Connection

7 Specifications

7.1 Absolute Maximum Ratings

Over operating free-air temperature range (unless otherwise noted)(1)

<table>
<thead>
<tr>
<th></th>
<th>MIN</th>
<th>MAX</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>Supply voltage VDD–VSS</td>
<td>−0.3</td>
<td>30</td>
<td>V</td>
</tr>
<tr>
<td>Input voltage V4–V3, V3–V2, V2–V1, V1–VSS, or CD–VSS</td>
<td>−0.3</td>
<td>30</td>
<td>V</td>
</tr>
<tr>
<td>Output voltage OUT–VSS</td>
<td>−0.3</td>
<td>30</td>
<td>V</td>
</tr>
<tr>
<td>Continuous total power dissipation, P&lt;sub&gt;TOT&lt;/sub&gt;</td>
<td>See Thermal Information</td>
<td></td>
<td></td>
</tr>
<tr>
<td>Lead temperature (soldering, 10 s), T&lt;sub&gt;SOLDER&lt;/sub&gt;</td>
<td>300</td>
<td></td>
<td>°C</td>
</tr>
<tr>
<td>Storage temperature, T&lt;sub&gt;stg&lt;/sub&gt;</td>
<td>−65</td>
<td>150</td>
<td></td>
</tr>
</tbody>
</table>

(1) Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

7.2 ESD Ratings

<table>
<thead>
<tr>
<th>V&lt;sub&gt;(ESD)&lt;/sub&gt;</th>
<th>Electrostatic discharge</th>
<th>VALUE</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>Human body model (HBM), per ANSI/ESDA/JEDEC JS-001&lt;sup&gt;(1)&lt;/sup&gt;</td>
<td>±2000</td>
<td>V</td>
<td></td>
</tr>
<tr>
<td>Charged device model (CDM), per JEDEC specification JESD22-C101&lt;sup&gt;(2)&lt;/sup&gt;</td>
<td>±500</td>
<td>V</td>
<td></td>
</tr>
</tbody>
</table>

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.
7.3 Recommended Operating Conditions

Over-operating free-air temperature range (unless otherwise noted)

<table>
<thead>
<tr>
<th>Parameter</th>
<th>MIN</th>
<th>MAX</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>Supply voltage, V&lt;sub&gt;DD&lt;/sub&gt;</td>
<td>3</td>
<td>20</td>
<td>V</td>
</tr>
<tr>
<td>Input voltage range V4–V3, V3–V2, V2–V1, V1–VSS, or CD–VSS</td>
<td>0</td>
<td>5</td>
<td>V</td>
</tr>
<tr>
<td>Operating ambient temperature range, T&lt;sub&gt;A&lt;/sub&gt;</td>
<td>–40</td>
<td>110</td>
<td>°C</td>
</tr>
</tbody>
</table>

7.4 Thermal Information

<table>
<thead>
<tr>
<th>THERMAL METRIC&lt;sup&gt;(1)&lt;/sup&gt;</th>
<th>bq2947</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>R&lt;sub&gt;θJA&lt;/sub&gt; Junction-to-ambient thermal resistance</td>
<td>62</td>
<td>°C/W</td>
</tr>
<tr>
<td>R&lt;sub&gt;θJC(top)&lt;/sub&gt; Junction-to-case(top) thermal resistance</td>
<td>72</td>
<td>°C/W</td>
</tr>
<tr>
<td>R&lt;sub&gt;θJB&lt;/sub&gt; Junction-to-board thermal resistance</td>
<td>32.5</td>
<td>°C/W</td>
</tr>
<tr>
<td>ψ&lt;sub&gt;JT&lt;/sub&gt; Junction-to-top characterization parameter</td>
<td>1.6</td>
<td>°C/W</td>
</tr>
<tr>
<td>ψ&lt;sub&gt;JB&lt;/sub&gt; Junction-to-board characterization parameter</td>
<td>33</td>
<td>°C/W</td>
</tr>
<tr>
<td>R&lt;sub&gt;θJC(bottom)&lt;/sub&gt; Junction-to-case(bottom) thermal resistance</td>
<td>10</td>
<td>°C/W</td>
</tr>
</tbody>
</table>

<sup>(1)</sup> For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.

7.5 Electrical Characteristics

Typical values stated where T<sub>A</sub> = 25°C and VDD = 14.4 V, MIN/MAX values stated where T<sub>A</sub> = –40°C to +110°C and V<sub>DD</sub> = 3 V to 20 V (unless otherwise noted).

<table>
<thead>
<tr>
<th>PARAMETER</th>
<th>TEST CONDITIONS</th>
<th>MIN</th>
<th>TYP</th>
<th>MAX</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>VOLTAGE PROTECTION THRESHOLDS</td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>V&lt;sub&gt;OV&lt;/sub&gt; V&lt;sub&gt;(PROTECT)&lt;/sub&gt; Overvoltage Detection</td>
<td>bq294700, R&lt;sub&gt;IN&lt;/sub&gt; = 1 kΩ</td>
<td>4.350</td>
<td>V</td>
<td></td>
<td></td>
</tr>
<tr>
<td></td>
<td>bq294701, R&lt;sub&gt;IN&lt;/sub&gt; = 1 kΩ</td>
<td>4.250</td>
<td>V</td>
<td></td>
<td></td>
</tr>
<tr>
<td></td>
<td>bq294702, R&lt;sub&gt;IN&lt;/sub&gt; = 1 kΩ</td>
<td>4.300</td>
<td>V</td>
<td></td>
<td></td>
</tr>
<tr>
<td></td>
<td>bq294703, R&lt;sub&gt;IN&lt;/sub&gt; = 1 kΩ</td>
<td>4.325</td>
<td>V</td>
<td></td>
<td></td>
</tr>
<tr>
<td></td>
<td>bq294704, R&lt;sub&gt;IN&lt;/sub&gt; = 1 kΩ</td>
<td>4.400</td>
<td>V</td>
<td></td>
<td></td>
</tr>
<tr>
<td></td>
<td>bq294705, R&lt;sub&gt;IN&lt;/sub&gt; = 1 kΩ</td>
<td>4.450</td>
<td>V</td>
<td></td>
<td></td>
</tr>
<tr>
<td></td>
<td>bq294706, R&lt;sub&gt;IN&lt;/sub&gt; = 1 kΩ</td>
<td>4.550</td>
<td>V</td>
<td></td>
<td></td>
</tr>
<tr>
<td></td>
<td>bq294707, R&lt;sub&gt;IN&lt;/sub&gt; = 1 kΩ</td>
<td>4.225</td>
<td>V</td>
<td></td>
<td></td>
</tr>
<tr>
<td></td>
<td>bq294708, R&lt;sub&gt;IN&lt;/sub&gt; = 1 kΩ</td>
<td>4.500</td>
<td>V</td>
<td></td>
<td></td>
</tr>
<tr>
<td></td>
<td>bq294711, R&lt;sub&gt;IN&lt;/sub&gt; = 1 kΩ</td>
<td>4.220</td>
<td>V</td>
<td></td>
<td></td>
</tr>
<tr>
<td></td>
<td>bq294712&lt;sup&gt;(1)&lt;/sup&gt;, R&lt;sub&gt;IN&lt;/sub&gt; = 1 kΩ</td>
<td>4.125</td>
<td>V</td>
<td></td>
<td></td>
</tr>
<tr>
<td></td>
<td>bq294713&lt;sup&gt;(1)&lt;/sup&gt;, R&lt;sub&gt;IN&lt;/sub&gt; = 1 kΩ</td>
<td>4.600</td>
<td>V</td>
<td></td>
<td></td>
</tr>
<tr>
<td>V&lt;sub&gt;HYS&lt;/sub&gt; OV Detection Hysteresis</td>
<td>bq2947&lt;sup&gt;(2)&lt;/sup&gt;</td>
<td>250</td>
<td>300</td>
<td>400</td>
<td>mV</td>
</tr>
<tr>
<td>V&lt;sub&gt;OA&lt;/sub&gt; OV Detection Accuracy</td>
<td>T&lt;sub&gt;A&lt;/sub&gt; = 25°C</td>
<td>–10</td>
<td>10</td>
<td></td>
<td>mV</td>
</tr>
<tr>
<td>V&lt;sub&gt;OADRIFT&lt;/sub&gt; OV Detection Accuracy Across Temperature</td>
<td>T&lt;sub&gt;A&lt;/sub&gt; = –40°C</td>
<td>–40</td>
<td>40</td>
<td></td>
<td>mV</td>
</tr>
<tr>
<td></td>
<td>T&lt;sub&gt;A&lt;/sub&gt; = 0°C</td>
<td>–20</td>
<td>20</td>
<td></td>
<td>mV</td>
</tr>
<tr>
<td></td>
<td>T&lt;sub&gt;A&lt;/sub&gt; = 60°C</td>
<td>–24</td>
<td>24</td>
<td></td>
<td>mV</td>
</tr>
<tr>
<td></td>
<td>T&lt;sub&gt;A&lt;/sub&gt; = 110°C</td>
<td>–54</td>
<td>54</td>
<td></td>
<td>mV</td>
</tr>
<tr>
<td>SUPPLY AND LEAKAGE CURRENT</td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>I&lt;sub&gt;DD&lt;/sub&gt; Supply Current</td>
<td>(V4–V3) = (V3–V2) = (V2–V1) = (V1–VSS) = 4.0 V at T&lt;sub&gt;A&lt;/sub&gt; = 25°C</td>
<td>1</td>
<td>2</td>
<td></td>
<td>µA</td>
</tr>
<tr>
<td>I&lt;sub&gt;IN&lt;/sub&gt; Input Current at Vx Pins</td>
<td>(V4–V3) = (V3–V2) = (V2–V1) = (V1–VSS) = 4.0 V at T&lt;sub&gt;A&lt;/sub&gt; = 25°C</td>
<td>–0.1</td>
<td>0.1</td>
<td></td>
<td>µA</td>
</tr>
</tbody>
</table>

<sup>(1)</sup> Contact TI for more information.
<sup>(2)</sup> Future option, contact TI.
## Electrical Characteristics (continued)

Typical values stated where $T_A = 25^\circ C$ and $VDD = 14.4 \, V$, MIN/MAX values stated where $T_A = -40^\circ C$ to $+110^\circ C$ and $V_{DD} = 3 \, V$ to $20 \, V$ (unless otherwise noted).

<table>
<thead>
<tr>
<th>PARAMETER</th>
<th>TEST CONDITIONS</th>
<th>MIN</th>
<th>TYP</th>
<th>MAX</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>$I_{CELL}$</td>
<td>Input Current (ALL $V_x$ and $VDD$ Input Pins)</td>
<td>Current Consumption at Power down, $(V4–V3) = (V3–V2) = (V2–V1) = (V1–VSS) = 2.30 , V$ at $T_A = 25^\circ C$</td>
<td>1.1</td>
<td></td>
<td></td>
</tr>
<tr>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td><strong>OUTPUT DRIVE OUT, CMOS ACTIVE HIGH VERSIONS ONLY</strong></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>$V_{OUT}$</td>
<td>Output Drive Voltage, Active High</td>
<td>If three of four cells are short circuited, only one cell remains powered and $&gt; V_{OV}$, $VDD = V_x$ (cell voltage), $I_{OH} = 100 , \mu A$</td>
<td>6</td>
<td>6</td>
<td></td>
</tr>
<tr>
<td></td>
<td></td>
<td>$(V4–V3), (V3–V2), (V2–V1), and (V1–VSS) &lt; V_{OV}$, $VDD = 14.4 , V$, $I_{OL} = 100 , \mu A$ measured into OUT pin.</td>
<td>250</td>
<td>400</td>
<td></td>
</tr>
<tr>
<td>$I_{OUTH}$</td>
<td>OUT Source Current (during OV)</td>
<td>$(V4–V3), (V3–V2), (V2–V1), or (V1–VSS) &gt; V_{OV}$, $VDD = 14.4 , V$, $OUT = 0 , V$, measured out of OUT pin.</td>
<td>4.5</td>
<td></td>
<td></td>
</tr>
<tr>
<td>$I_{OUTL}$</td>
<td>OUT Sink Current (no OV)</td>
<td>$(V4–V3), (V3–V2), (V2–V1), and (V1–VSS) &lt; V_{OV}$, $VDD = 14.4 , V$, $OUT = VDD$, measured into OUT pin. Pull resistor $R_{PU} = 5 , k\Omega$ to $VDD = 14.4 , V$</td>
<td>0.5</td>
<td>14</td>
<td></td>
</tr>
<tr>
<td><strong>OUTPUT DRIVE OUT, CMOS OPEN DRAIN ACTIVE LOW VERSIONS ONLY</strong></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>$V_{OUT}$</td>
<td>Output Drive Voltage, Active High</td>
<td>$(V4–V3), (V3–V2), (V2–V1), and (V1–VSS) &lt; V_{OV}$, $VDD = 14.4 , V$, $I_{OL} = 100 , \mu A$ measured into OUT pin.</td>
<td>250</td>
<td>400</td>
<td></td>
</tr>
<tr>
<td>$I_{OUTL}$</td>
<td>OUT Sink Current (no OV)</td>
<td>$(V4–V3), (V3–V2), (V2–V1), and (V1–VSS) &lt; V_{OV}$, $VDD = 14.4 , V$, $OUT = VDD$, measured into OUT pin. Pull resistor $R_{PU} = 5 , k\Omega$ to $VDD = 14.4 , V$</td>
<td>0.5</td>
<td>14</td>
<td></td>
</tr>
<tr>
<td>$I_{OUTLK}$</td>
<td>OUT pin leakage</td>
<td>$(V4–V3), (V3–V2), (V2–V1), and (V1–VSS) &lt; V_{OV}$, $VDD = 14.4 , V$, $OUT = VDD$, measured into OUT pin.</td>
<td>100</td>
<td></td>
<td></td>
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<tr>
<td><strong>DELAY TIMER</strong></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>$I_{CD}$</td>
<td>OV Delay Time</td>
<td>$C_{CD} = 0.1 , \mu F$ (see Equation 1)</td>
<td>1</td>
<td>1.5</td>
<td>2</td>
</tr>
<tr>
<td>$I_{CD, GND}$</td>
<td>OV Delay Time with CD pin = 0 $V$</td>
<td>Delay due to $C_{CD}$ capacitor shorted to ground for Customer Test Mode</td>
<td>20</td>
<td></td>
<td>170</td>
</tr>
</tbody>
</table>
7.6 Typical Characteristics

Figure 1. Overvoltage Threshold (Nominal = 4.35 V) vs. Temperature

Figure 2. Hysteresis $V_{HYS}$ vs. Temperature

Figure 3. $I_{DD}$ Current Consumption vs. Temperature at $V_{DD} = 16$ V

Figure 4. $I_{CELL}$ vs. Temperature at $V_{CELL} = 9.2$ V

Figure 5. Output Current $I_{OUT}$ vs. Temperature

Figure 6. $V_{OUT}$ vs. $V_{DD}$
8 Detailed Description

8.1 Overview
The bq2947 is a second level overvoltage (OV) protector. Each cell is monitored independently by comparing the actual cell voltage to a protection voltage threshold, $V_{OV}$. The protection threshold is preprogrammed at the factory with a range between 3.85 V and 4.65 V.

8.2 Functional Block Diagram
The Functional Block Diagram shows a CMOS Active High configuration.

In the case of an Open Drain Active Low configuration, an external pull-up resistor is required on the OUT terminal.

8.3 Feature Description
In the bq2947 family of devices, if any cell voltage exceeds the programmed OV value, a timer circuit is activated. This timer circuit charges the CD pin to a nominal value, then slowly discharges it with a fixed current back down to VSS. When the CD pin falls below a nominal threshold near VSS, the OUT terminal goes from inactive to active state. Additionally, a timeout detection circuit checks to ensure that the CD pin successfully begins charging to above VSS and subsequently drops back down to VSS, and if a timeout error is detected in either direction, it will similarly trigger the OUT pin to become active. See Figure 8 for details on CD and OUT pin behavior during an overvoltage event.
Feature Description (continued)

For an NCH Open Drain Active Low configuration, the OUT pin pulls down to VSS when active (OV present) and is high impedance when inactive (no OV).

![Figure 7. Timing for Overvoltage Sensing (OUT Pin Is Active High)](image)

**Figure 7. Timing for Overvoltage Sensing (OUT Pin Is Active High)**

**Figure 8** shows the behavior of CD pin during an OV sequence.

![Figure 8. CD Pin Mechanism (OUT Pin Is Active High)](image)

**Figure 8. CD Pin Mechanism (OUT Pin Is Active High)**

**NOTE**

In the case of an Open Drain Active Low version, the \( V_{OUT} \) signal will be high and transition to low state when the voltage on the \( V_{CD} \) capacitor discharges to the set level based on the \( t_{CD} \) timer.
Feature Description (continued)

8.3.1 Pin Details

8.3.1.1 Input Sense Voltage, \( V_x \)
These inputs sense each battery cell voltage. A series resistor and a capacitor across the cell for each input is required for noise filtering and stable voltage monitoring.

8.3.1.2 Output Drive, \( \text{OUT} \)
This terminal serves as the fault signal output, and may be ordered in either Active High or Open Drain Active Low options.

8.3.1.3 Supply Input, \( VDD \)
This terminal is the unregulated input power source for the IC. A series resistor is connected to limit the current, and a capacitor is connected to ground for noise filtering.

8.3.1.4 External Delay Capacitor, \( CD \)
This terminal is connected to an external capacitor that sets the delay timer during an overvoltage fault event. The \( CD \) pin includes a timeout detection circuit to ensure that the output drives active even with a shorted or open capacitor during an overvoltage event.

The capacitor connected on the \( CD \) pin rapidly charges to a voltage if any one of the cell inputs exceeds the \( OV \) threshold. Then the delay circuit gradually discharges the capacitor on the \( CD \) pin. Once this capacitor discharges below a set voltage, the \( \text{OUT} \) transitions from an inactive to active state.

To calculate the delay, use the following equation:
\[
t_{\text{CD}} \text{(sec)} = K \times C_{\text{CD}} \text{ (µF)}, \text{ where } K = 10 \text{ to } 20 \text{ range. } (1)
\]

Example: If \( C_{\text{CD}} = 0.1 \text{ µF} \) (typical), then the delay timer range is
\[
t_{\text{CD}} \text{(s)} = 10 \times 0.1 = 1 \text{ s (Minimum)}
\]
\[
t_{\text{CD}} \text{(s)} = 20 \times 0.1 = 2 \text{ s (Maximum)}
\]

**NOTE**
The tolerance on the capacitor used for \( C_{\text{CD}} \) increases the range of the \( t_{\text{CD}} \) timer.

8.4 Device Functional Modes

8.4.1 NORMAL Mode
When all of the cell voltages are below the overvoltage threshold, \( V_{OV} \), the device operates in NORMAL mode. The device monitors the differential cell voltages connected across \((V1–VSS), (V2–V1), (V3–V2), \) and \((V4–V3)\). The \( \text{OUT} \) pin is inactive, and is low if configured active high, or, if configured active low, is an open drain being externally pulled up.

8.4.2 OVERVOLTAGE Mode
OVERVOLTAGE mode is detected if any of the cell voltage exceeds the overvoltage threshold, \( V_{OV} \) for configured \( OV \) delay time. The \( \text{OUT} \) pin is activated after a delay time set by the capacitance in the \( CD \) pin. The \( \text{OUT} \) pin will either pull high internally, if configured as active high, or will be pulled low internally if configured as active low. An external FET is then turned on, shorting the fuse to ground, which allows the battery and/or charger power to blow the fuse. When all of the cell voltages fall below the \((V_{OV}–V_{HYS})\), the device returns to NORMAL mode.

8.4.3 Customer Test Mode
It is possible to reduce test time for checking the overvoltage function by simply shorting the external \( CD \) capacitor to \( VSS \). In this case, the \( OV \) delay would be reduced to the \( t_{\text{CD, GND}} \) value, which has a maximum of 170 ms.
Device Functional Modes (continued)

Figure 9 shows the timing for the Customer Test Mode.

![Figure 9. Timing for Customer Test Mode](image)

Figure 10 shows the measurement for current consumption of the product for both VDD and Vx.

![Figure 10. Configuration for IC Current Consumption Test](image)
9 Application and Implementation

NOTE
Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI’s customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

9.1 Application Information

The bq2947 devices are a family of second-level protectors used for overvoltage protection of the battery pack in the application. The device, when configuring the OUT pin with active high, drives a NMOS FET that connects the fuse to ground in the event of a fault condition. This provides a shorted path to use the battery and/or charger power to blow the fuse and cut the power path. The OUT pin, when configured as active low, can be used to drive a PMOS FET to connect the fuse to ground instead.

9.2 Typical Applications

9.2.1 Application Configuration for Active High

Figure 11 shows the recommended reference design components.

Figure 11. Application Configuration for Active High

9.2.1.1 Design Requirements

NOTE
In the case of an Open Drain Active Low configuration, an external pull-up resistor is required on the OUT terminal.

Changes to the ranges stated in Table 1 will impact the accuracy of the cell measurements.

Table 1. Parameters

<table>
<thead>
<tr>
<th>PARAMETER</th>
<th>EXTERNAL COMPONENT</th>
<th>MIN</th>
<th>NOM</th>
<th>MAX</th>
<th>UNIT</th>
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<tbody>
<tr>
<td>Voltage monitor filter resistance</td>
<td>R_{IN}</td>
<td>900</td>
<td>1000</td>
<td>4700</td>
<td>Ω</td>
</tr>
<tr>
<td>Voltage monitor filter capacitance</td>
<td>C_{IN}</td>
<td>0.01</td>
<td>0.1</td>
<td>1.0</td>
<td>µF</td>
</tr>
<tr>
<td>Supply voltage filter resistance</td>
<td>R_{VD}</td>
<td>100</td>
<td></td>
<td>1000</td>
<td>Ω</td>
</tr>
<tr>
<td>Supply voltage filter capacitance</td>
<td>C_{VD}</td>
<td></td>
<td>0.1</td>
<td>1.0</td>
<td>µF</td>
</tr>
<tr>
<td>CD external delay capacitance</td>
<td>C_{CD}</td>
<td></td>
<td>0.1</td>
<td>1.0</td>
<td>µF</td>
</tr>
</tbody>
</table>
NOTE
The device is calibrated using an $R_{IN}$ value = 1 kΩ. Using a value other than this recommended value changes the accuracy of the cell voltage measurements and $V_{OV}$ trigger level.

9.2.1.2 Detailed Design Procedure
1. Determine the number of cell in series.
   The device supports 2-S to 4-S cell configuration. For 2S and 3S, the top unused pin(s) should be shorted as shown in Figure 12 and Figure 13.
2. Determine the overvoltage protection delay.
   Follow the calculation example described in CD pin description. Select the right capacitor to connect to the CD pin.
3. Follow the application schematic to connect the device. If the OUT pin is configured to open drain, an external pull up resistor should be used.

Figure 12. 2-Series Cell Configuration

Figure 13. 3-Series Cell Configuration
### 9.2.1.3 Application Curves

#### Figure 14. Overvoltage Threshold (OVT) vs. Temperature

![Graph showing Overvoltage Threshold (OVT) vs. Temperature](image1)

#### Figure 15. Hysteresis $V_{HYS}$ vs. Temperature

![Graph showing Hysteresis $V_{HYS}$ vs. Temperature](image2)

#### Figure 16. $I_{DD}$ Current Consumption vs. Temperature at $V_{DD} = 16$ V

![Graph showing $I_{DD}$ Current Consumption vs. Temperature at $V_{DD} = 16$ V](image3)

#### Figure 17. $V_{OUT}$ vs. $V_{DD}$

![Graph showing $V_{OUT}$ vs. $V_{DD}$](image4)
10 Power Supply Recommendations

The maximum power of this device is 20 V on $V_{DD}$.

11 Layout

11.1 Layout Guidelines

1. Ensure the RC filters for the Vx pins and VDD pin are placed as close as possible to the target terminal, reducing the tracing loop area.
2. The capacitor for CD should be placed close to the IC terminals.
3. Ensure the trace connecting the fuse to the gate, source of the NFET to the Pack– is sufficient to withstand the current during fuse blown event.

11.2 Layout Example

![Layout Example Diagram]

Figure 18. Layout Example
12 Device and Documentation Support

12.1 Documentation Support

12.1.1 Related Documentation
For related documentation, see bq2945xy and bq2947xy Cascade Voltage Monitoring (SLUA662).

12.2 Receiving Notification of Documentation Updates
To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on Alert me to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

12.3 Community Resources
The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI’s views; see TI’s Terms of Use.

TI E2E™ Online Community TI’s Engineer-to-Engineer (E2E) Community. Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

Design Support TI’s Design Support Quickly find helpful E2E forums along with design support tools and contact information for technical support.

12.4 Trademarks
PowerPAD, E2E are trademarks of Texas Instruments.
All other trademarks are the property of their respective owners.

12.5 Electrostatic Discharge Caution
This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

12.6 Glossary
SLYZ022 — TI Glossary.
This glossary lists and explains terms, acronyms, and definitions.

13 Mechanical, Packaging, and Orderable Information
The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.
NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.
EXAMPLE BOARD LAYOUT

**DSG0008B**

**WSON - 0.8 mm max height**

**PLASTIC SMALL OUTLINE - NO LEAD**

---

**NOTES: (continued)**

4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).

5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.
EXAMPLE STENCIL DESIGN

DSG0008B

WSON - 0.8 mm max height

PLASTIC SMALL OUTLINE - NO LEAD

SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL

EXPOSED PAD 9:
87% PRINTED SOLDER COVERAGE BY AREA UNDER PACKAGE
SCALE:25X

SYMM
1
4
5
8
METAL
SYMM
9

NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
<table>
<thead>
<tr>
<th>Orderable Device</th>
<th>Status</th>
<th>Package Type</th>
<th>Package Drawing</th>
<th>Pins</th>
<th>Package Qty</th>
<th>Eco Plan</th>
<th>Lead/Ball Finish</th>
<th>MSL Peak Temp</th>
<th>Op Temp (°C)</th>
<th>Device Marking</th>
<th>Samples</th>
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<td>-40 to 85</td>
<td>711</td>
<td><img src="Images/Samples.png" alt="" /></td>
</tr>
</tbody>
</table>

(1) The marketing status values are defined as follows:

**ACTIVE**: Product device recommended for new designs.

**LIFEBUY**: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND**: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW**: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE**: TI has discontinued the production of the device.

(2) **RoHS**: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

**RoHS Exempt**: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

**Green**: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) **MSL, Peak Temp.**: The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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TAPE AND REEL INFORMATION

**REEL DIMENSIONS**

**TAPE DIMENSIONS**

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<tr>
<th>Device</th>
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<th>SPQ</th>
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### Tape and Reel Box Dimensions

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Pack Materials-Page 2
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This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.
NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.
NOTES: (continued)

4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).

5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.
NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
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